

Abstracts

Characteristics of broadband InP millimeter-wave amplifiers for radiometry

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The performance of InP HEMT (High-Electron Mobility Transistor) amplifiers is characterized in a direct detection 3.8 mm receiver over a temperature range of 50 to 300 K. The effects of low frequency noise up-conversion are observed in the total power response. The measured spectrum of gain fluctuations at room temperature is characterized by $\delta g \propto f^{-2}$, with an index $\alpha \approx 0.9$ and $\delta g \propto 10^{-9} \text{ Hz}^{-1}$ per device used in the amplification chain. When the devices are cooled to 50 K, $\delta g \propto 10^{-2}$ increases by a factor of 5. The measured receiver sensitivity is $3 \text{ mK Hz}^{-1/2}$ at an ambient temperature of 300 K and $0.8 \text{ mK Hz}^{-1/2}$ at 50 K. The measured sensitivity at room temperature is the best reported for a HEMT direct detection receiver in the 3 mm atmospheric window. At 50 K the observed receiver sensitivity is competitive with the performance of sub-Kelvin bolometric detectors or SIS junctions used for direct detection.

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